

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/785,617	LOOK, CHRISTOPHER M.	
				Examiner	Art Unit	
				DANNY W. LEUNG	2613	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
398	19, 16, 22, 12	1/16/2007	DWL	Searched EAST, Keyword Search, see search history printout.	1/17/2007	DWL
398	19, 22	1/7/2009	DWL			
398	22,23,24	5/30/2009	DWL	Searched EAST, Keyword Search, see search history printout.	9/13/2007	DWL
398	12,19	5/30/2009	DWL			
398	16,32	5/30/2009	DWL	updated search, eDAN inventor search, Searched EAST, Keyword Search, see search history printout.	3/4/2008	DWL
398	12	5/25/2010	DWL			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			
398	12, 19	10/13/2010	DWL			